## Notice of References Cited Application/Control No. 10/533,130 Examiner Shaheda A. Abdin Applicant(s)/Patent Under Reexamination KAWASE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0018032 A1	02-2002	Weitbruch et al.	345/60
*	В	US-6,388,643 B1	05-2002	Huang, Jih Fon	345/60
*	С	US-2004/0085262 A1	05-2004	Lee, Joo-Yul	345/041
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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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